

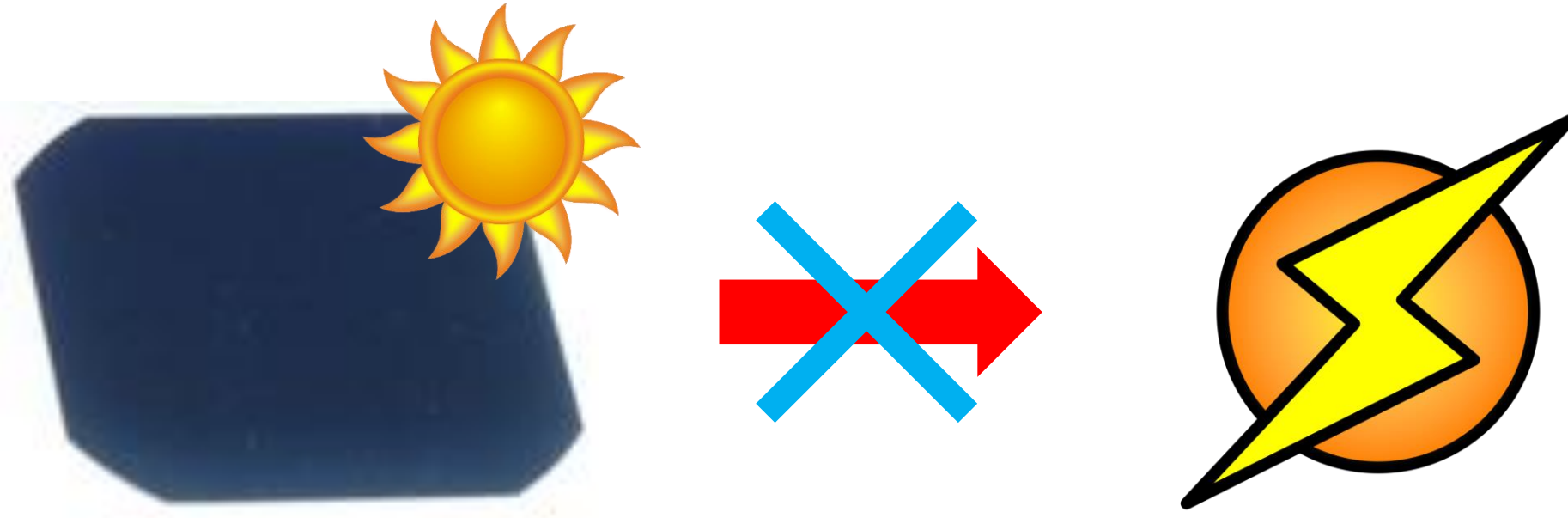
# Assessing end-of-life failure modes in PV modules

Andrew Fairbrother

PEARL PV WG2 webinar – 2 February 2020

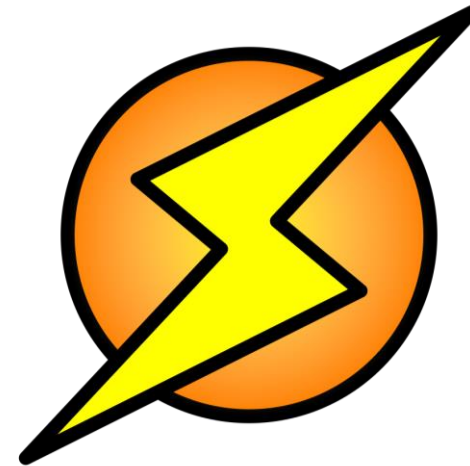
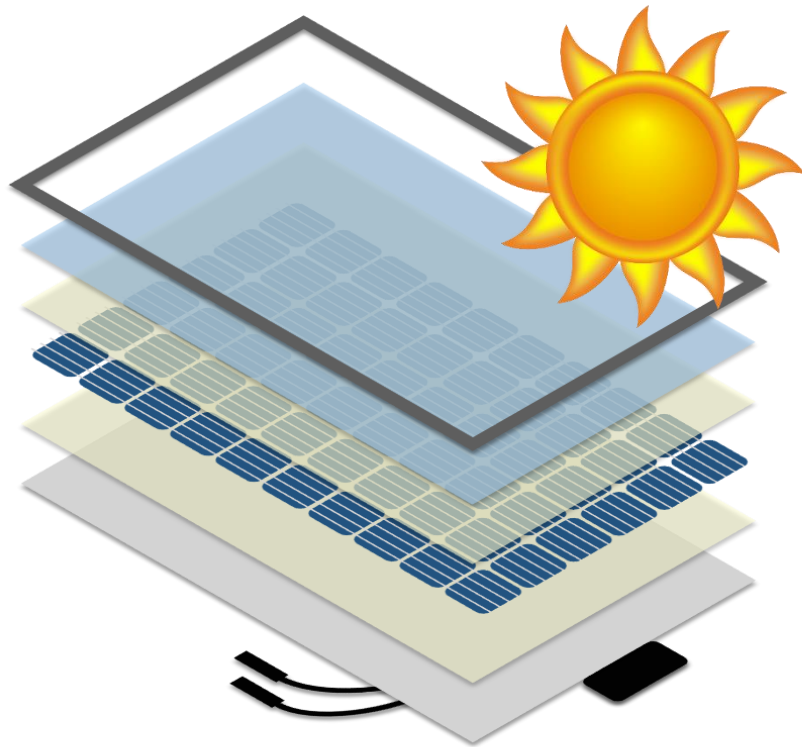
# PV modules

Modules are more than silicon

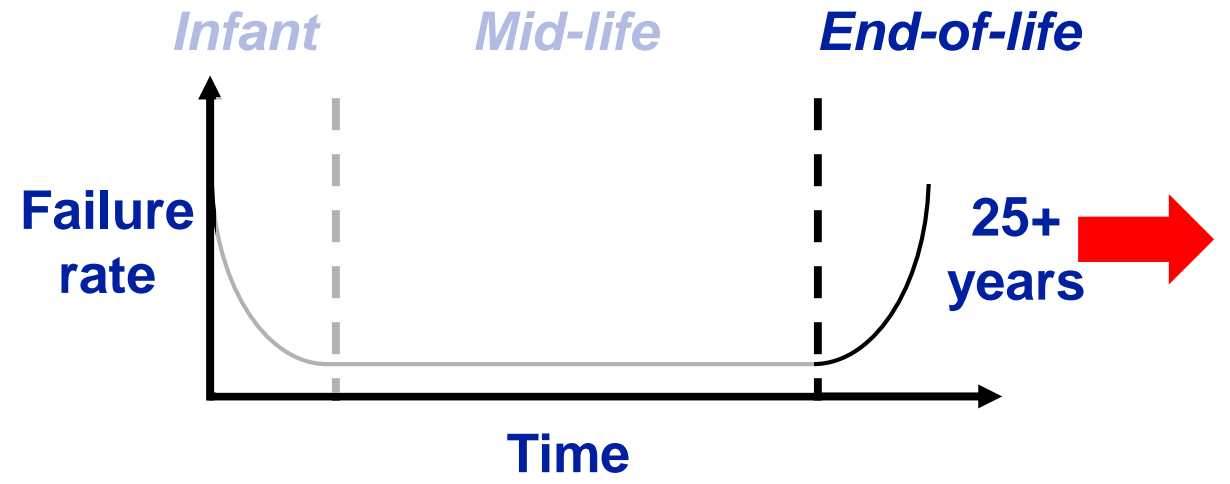
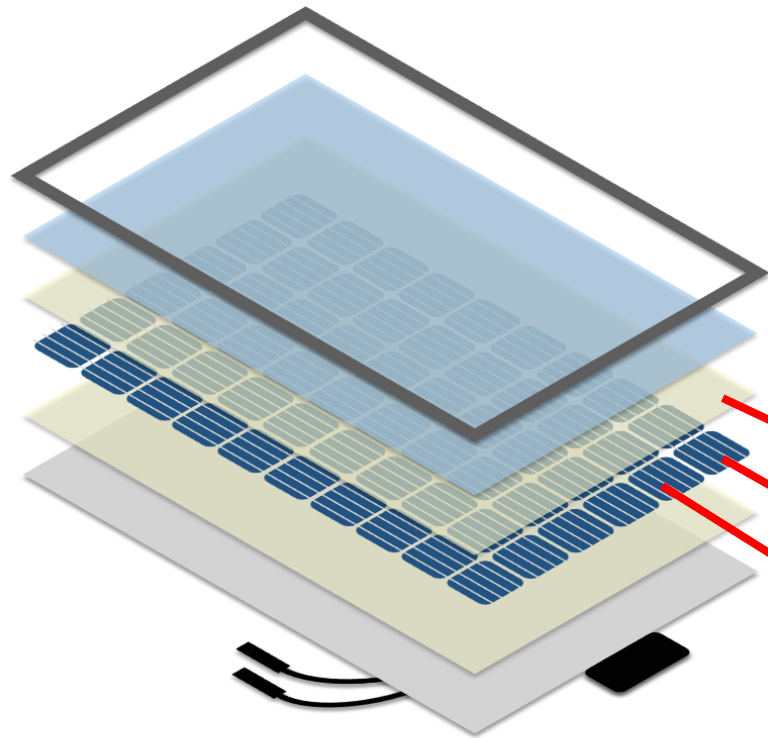


# PV modules

Modules are more than silicon



# Module end-of-life failure



- Packaging delamination
- Cell and interconnect corrosion
- Cracked cell isolation

# Risk factors for end-of-life failure

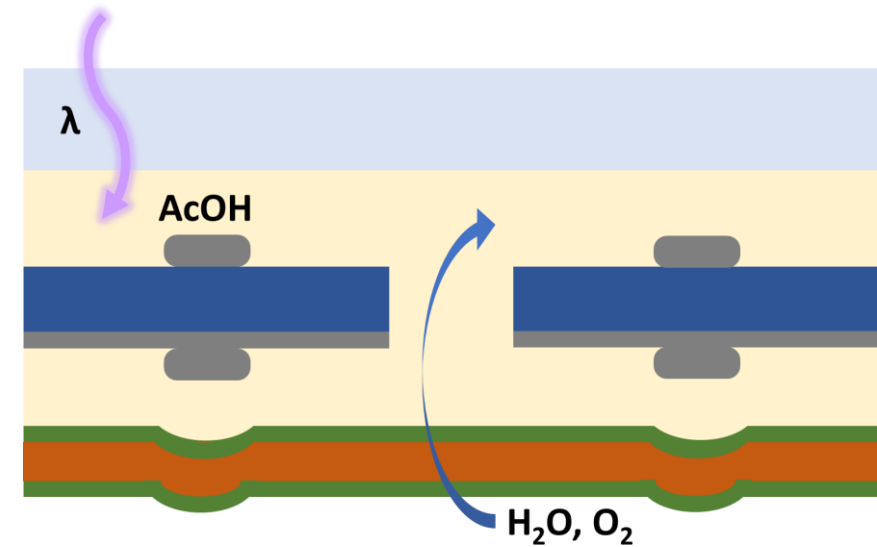
## Delamination:

- BOM quality, compatibility
- Process (lamination) quality
- Interface degradation



## Corrosion:

- Moisture ingress
- EVA degradation (acetic acid generation)
- Electrical currents

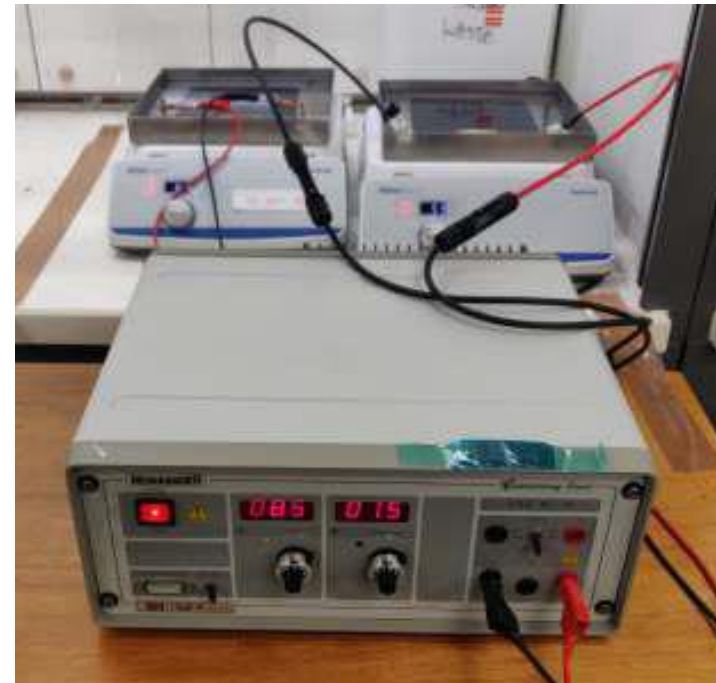


# Test to failure

## 1. Accelerated delamination tests



## 2. Accelerated acid corrosion tests

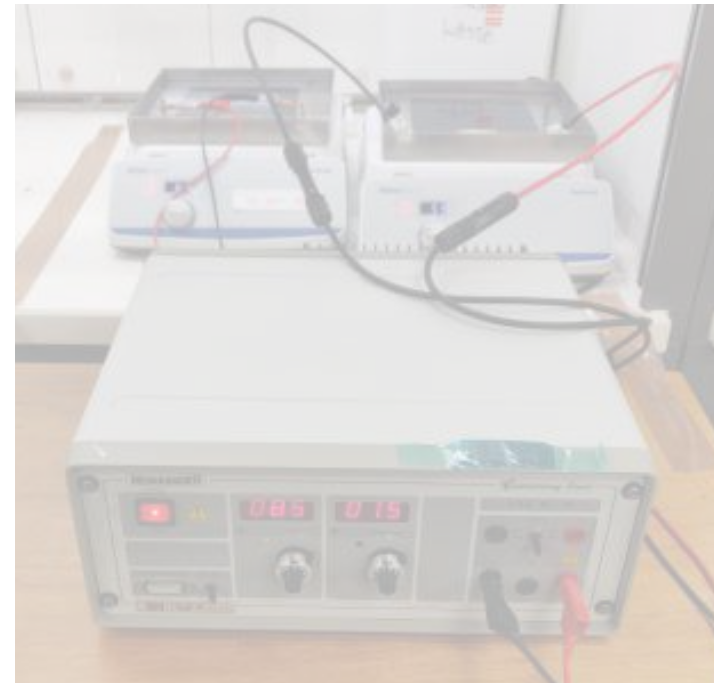


# Test to failure

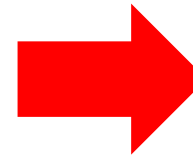
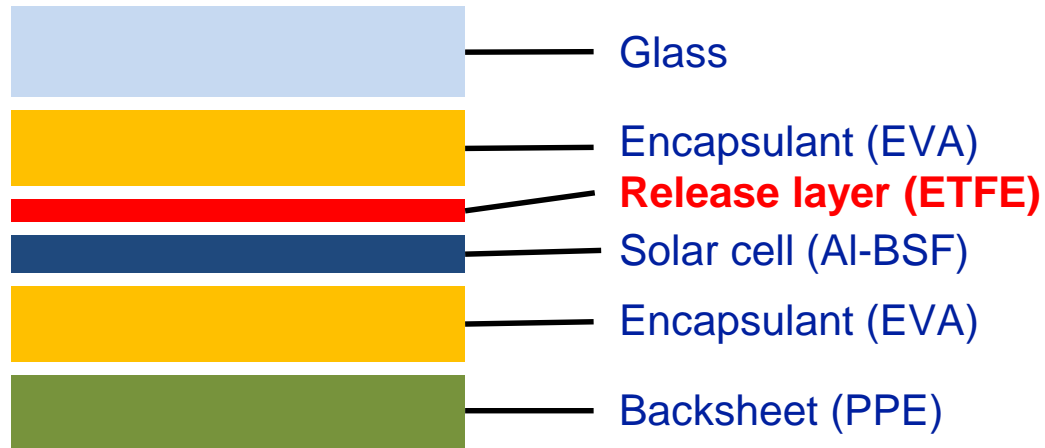
## 1. Accelerated delamination tests



## 2. Accelerated acid corrosion tests



# Accelerated delamination tests



Weathering test	Conditions
Damp heat	85°C/85% RH
Thermal cycling	-40°C to 85°C
UV	UVA fluor. 0.7 W m <sup>-2</sup> (@340 nm), 65°C
Outdoor	Neuchâtel, CH

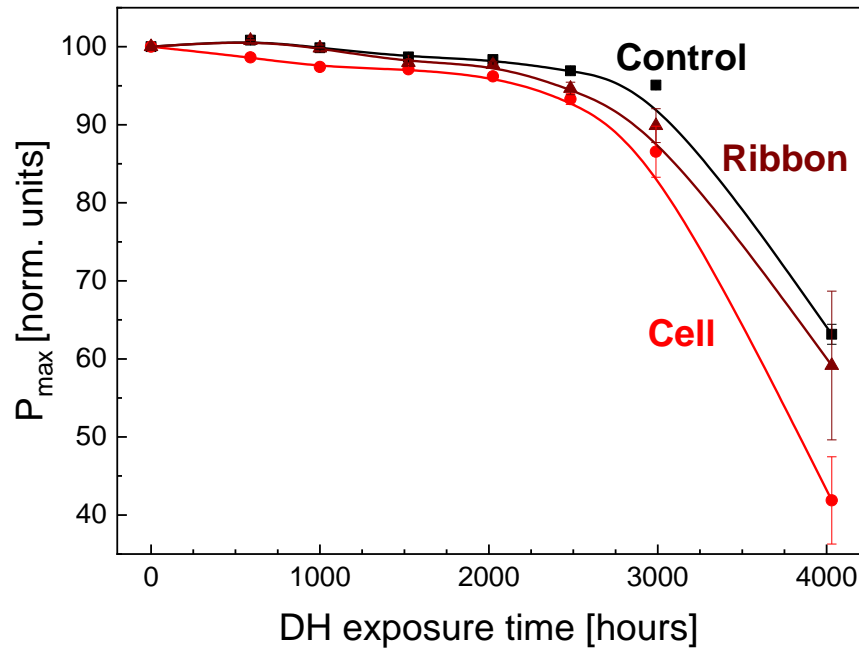
Increasing delamination area



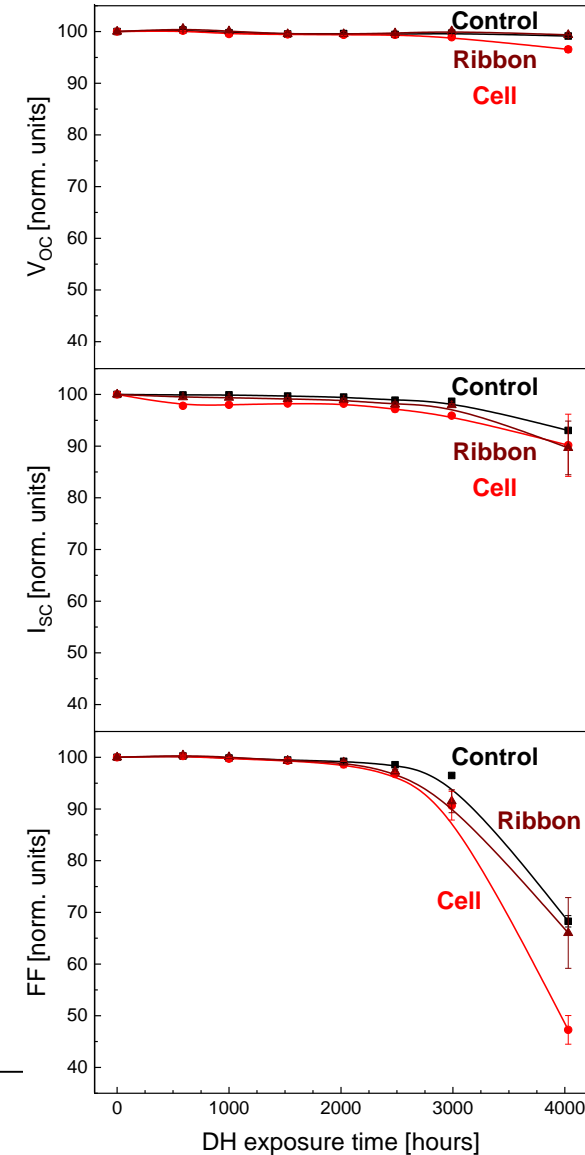


# Delamination: module performance

>2 times rate of power loss for full cell delamination in damp heat



Increasing delamination area



Open circuit voltage



Short circuit current

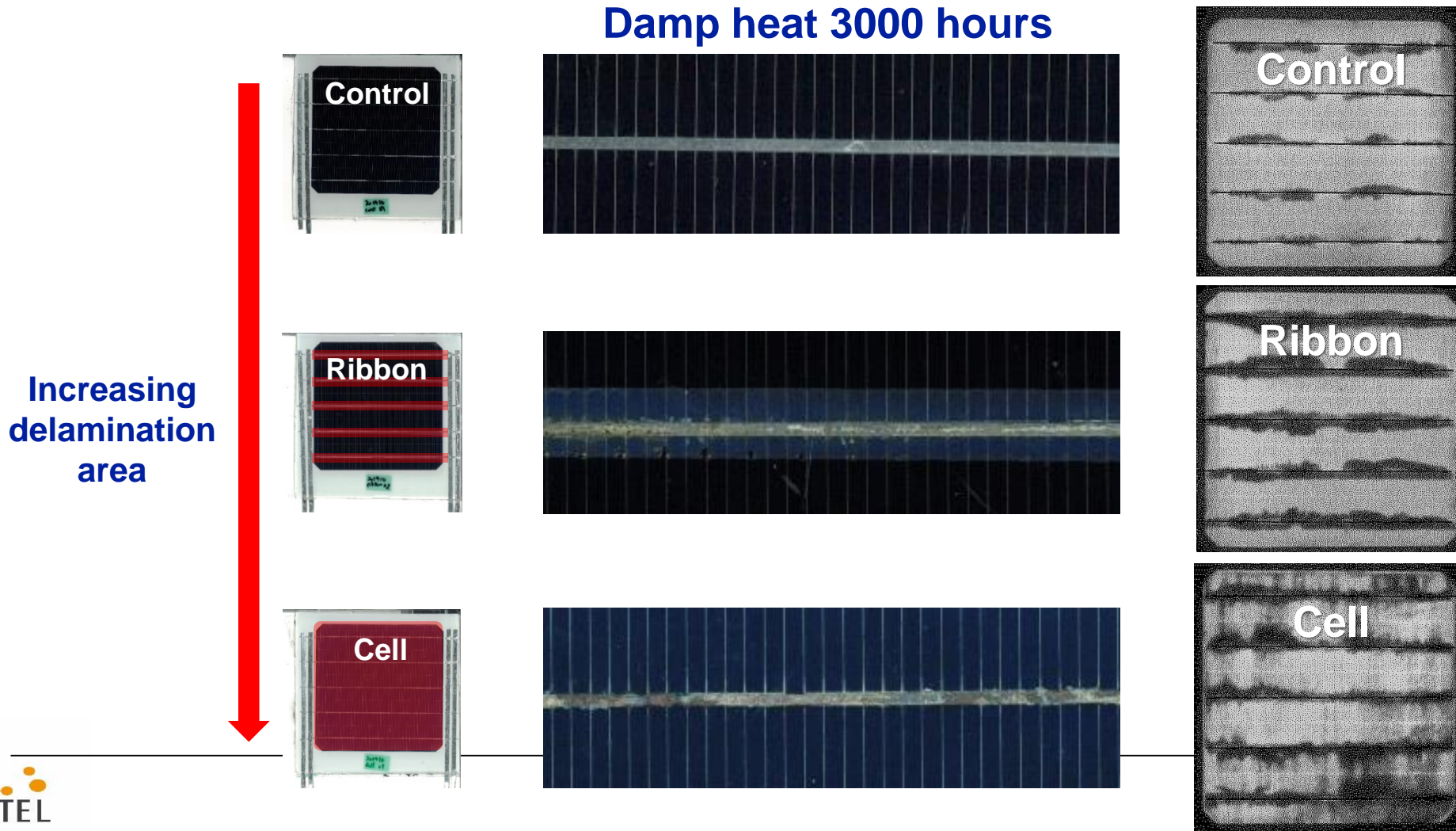


Fill factor



# Delamination: degradation mechanism

Delamination facilitates corrosion

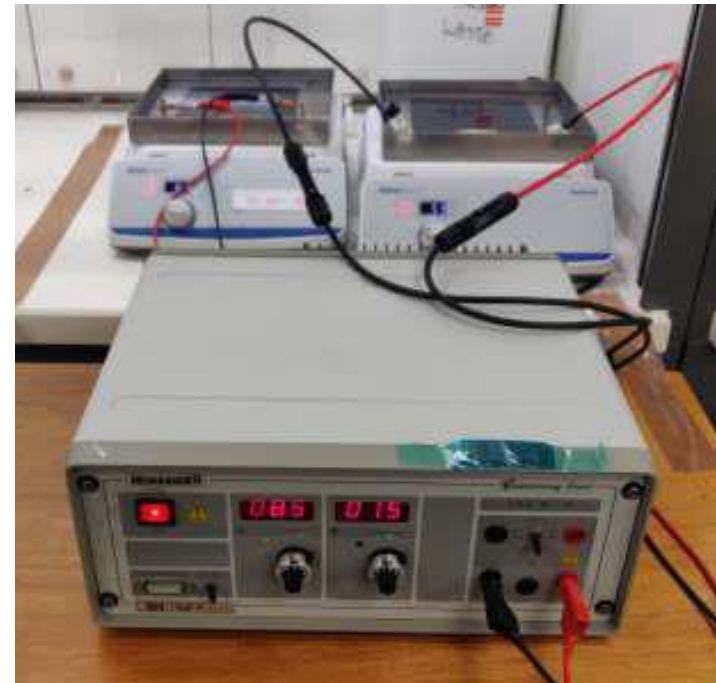


# Test to failure

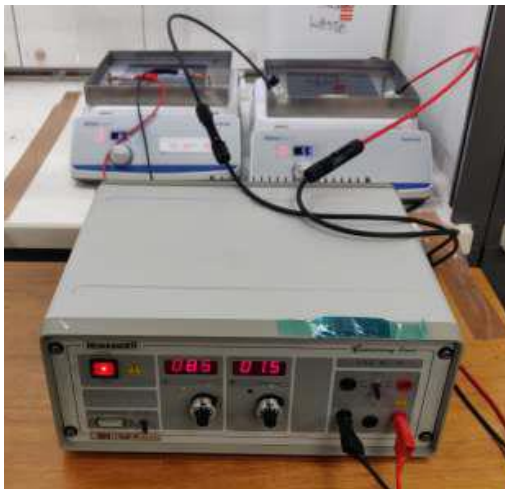
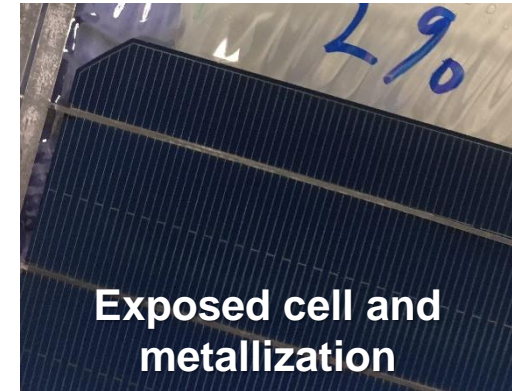
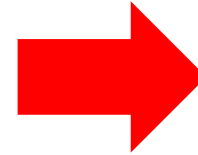
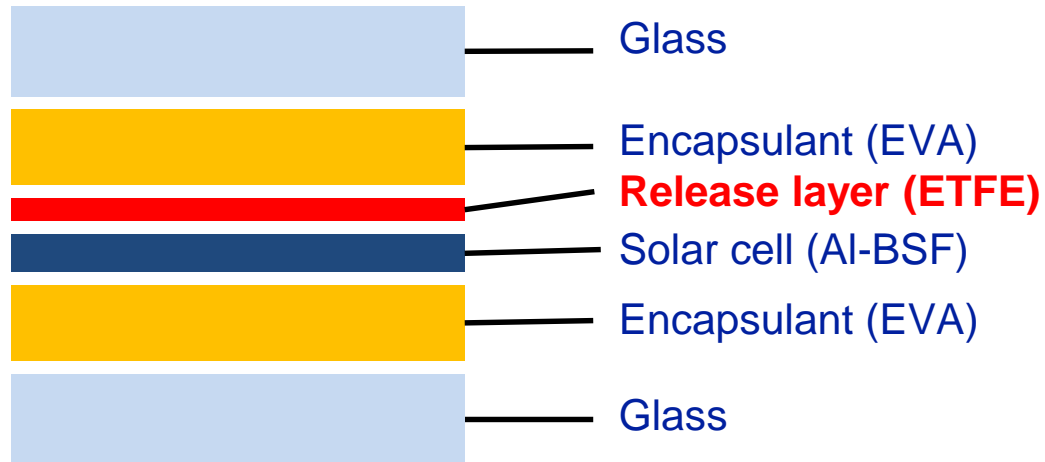
## 1. Accelerated delamination tests



## 2. Accelerated acid corrosion tests



# Accelerated acid corrosion tests

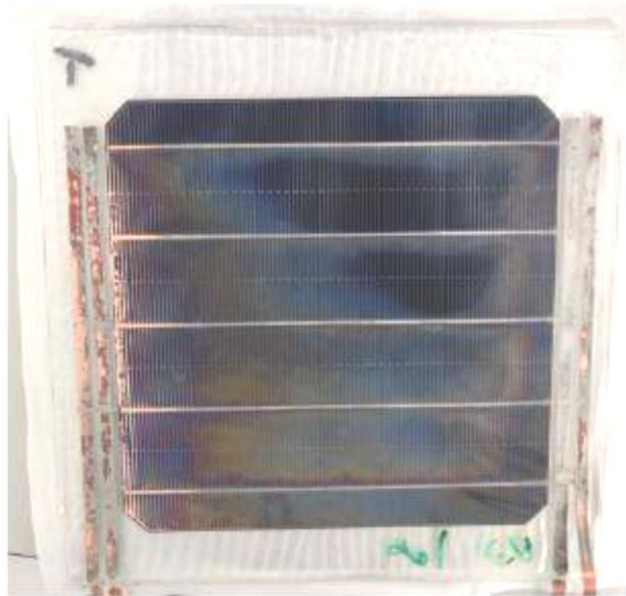


	Acid conc. [v/v%]	Temperature [°C]	Electrical bias [A]
	0	20	0
	<b>*0.1</b>	40	<b>*8.5</b>
<b>Acetic acid</b>	1.0	<b>*60</b>	
	2.0	<b>*80</b>	
	5.0		
	10.0		

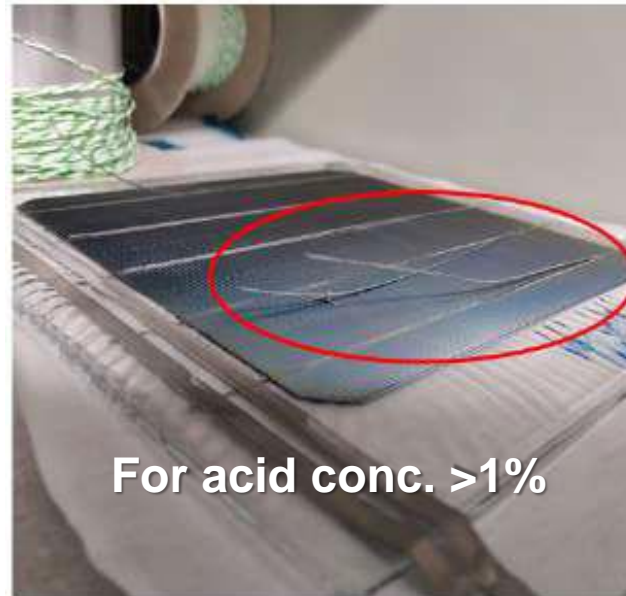
**\*Realistic worst-case field conditions**

# Corrosion: visual evidence

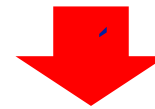
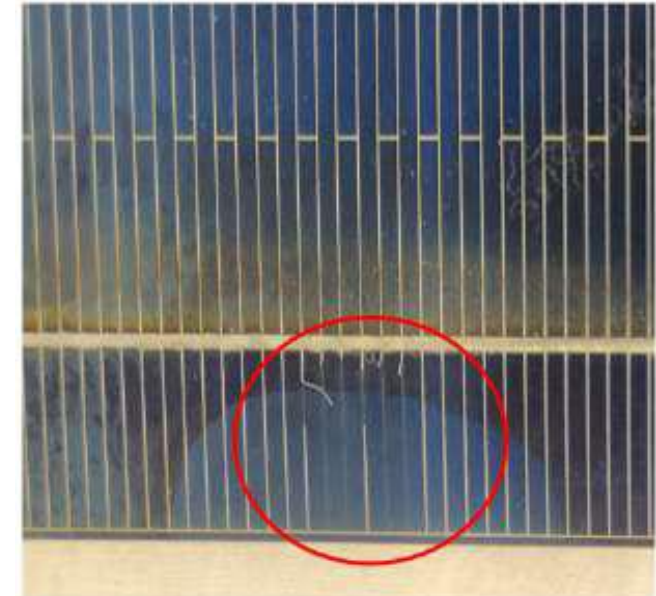
Discoloration



Ribbon detachment



Finger detachment

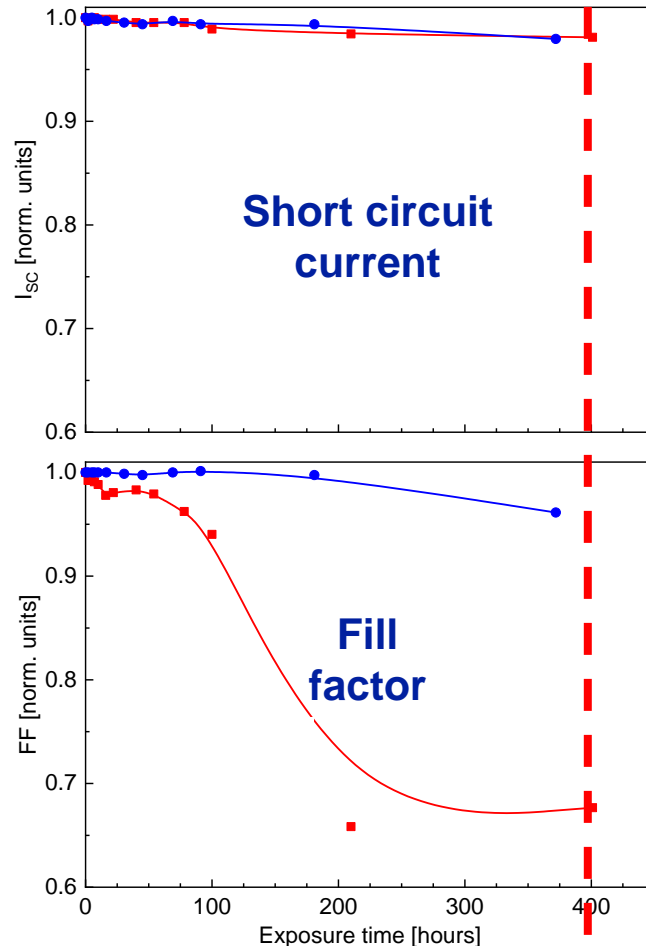


Tests with >1% acid  
too aggressive

# Corrosion: module performance

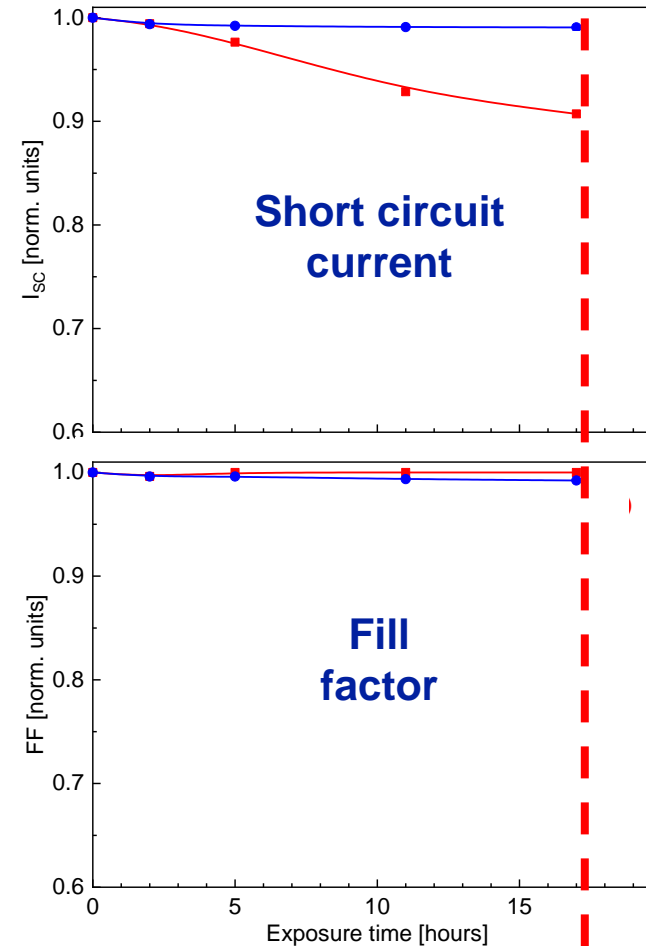
Application of bias accelerates corrosion, alters loss mechanism

Water  
1% acid  
60°C  
No bias



FF loss dominates

400 hours



Water  
1% acid  
60°C  
8.5 bias

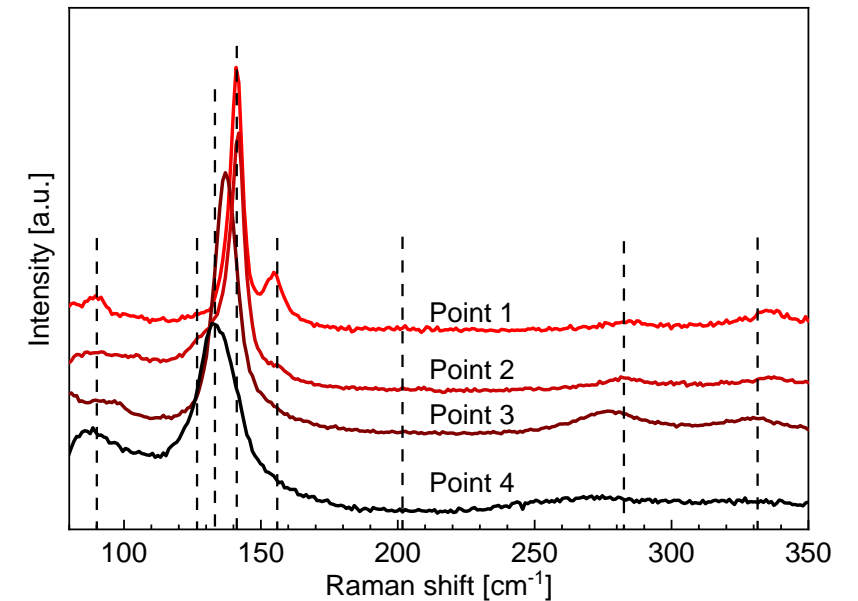
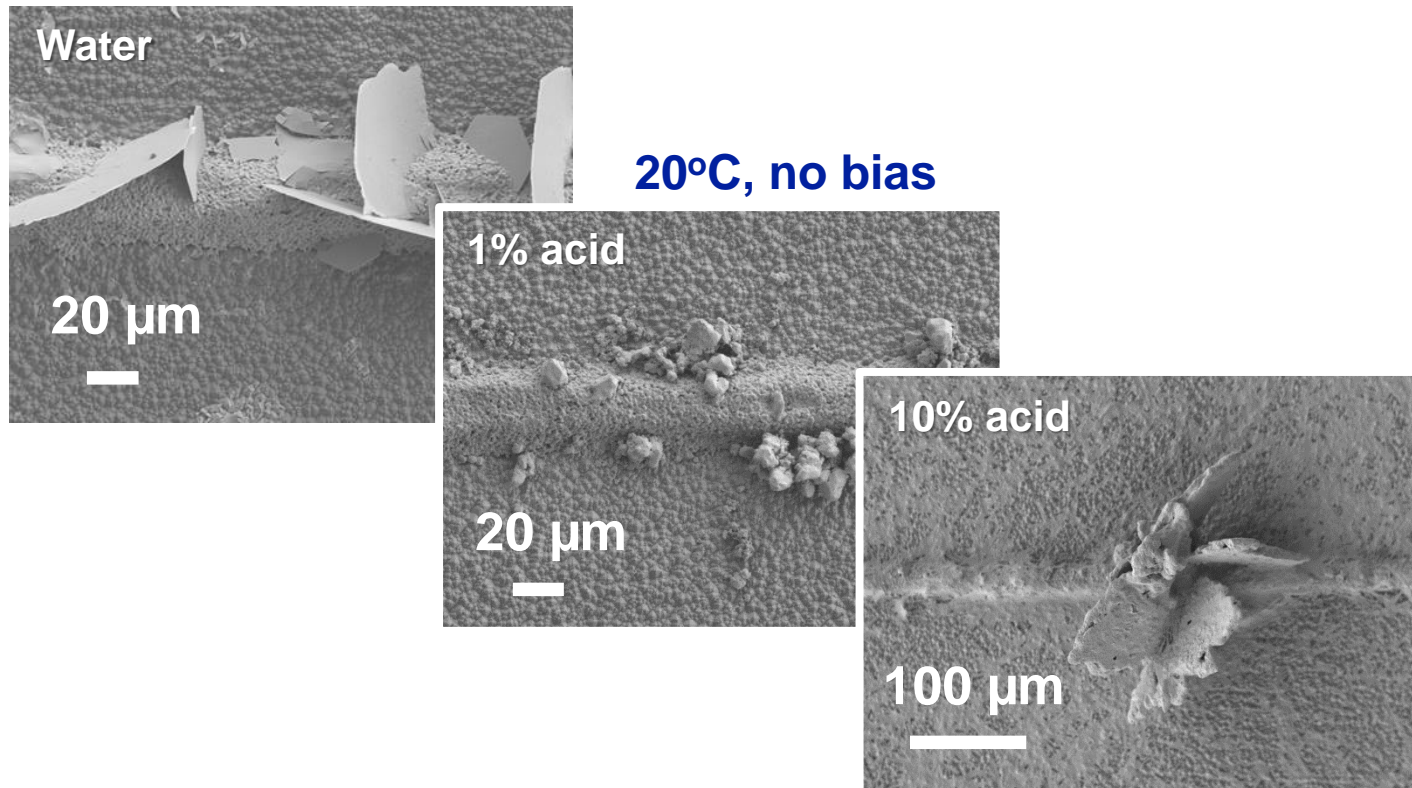


$I_{sc}$  loss dominates

17 hours

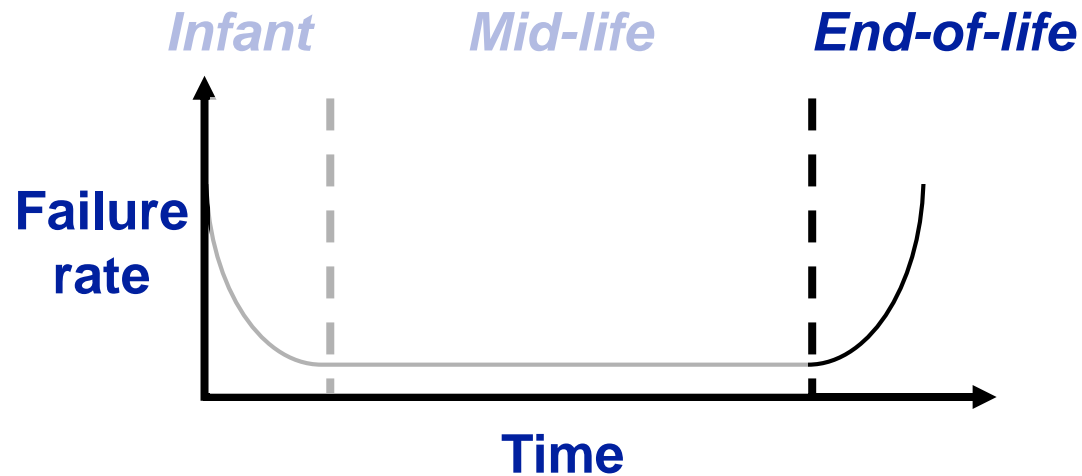
# Corrosion: degradation products

$\text{PbO}_2$  main corrosion product for all conditions, accumulation along fingers, busbar



# Conclusions

Isolate degradation/failure mode for test with non-conventional specimen and test design



Targeted testing for failure to expose weaknesses in product design

